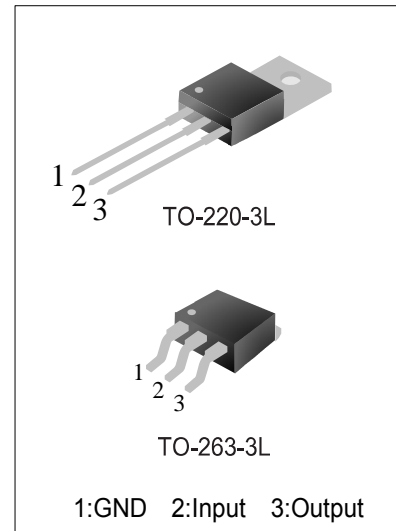


FEATURES:

- Output current in excess of 1.0A
- Internal short current circuit limiting
- Internal thermal overload protection
- Output voltage offered of 4% tolerance



ORDERING INFORMATION:

DEVICE	Package Type	MARKING	Packing	Packing Qty
LM7905T	TO220-3L	LM7905	TUBE	1000pcs/box
LM7906T	TO220-3L	LM7906	TUBE	1000pcs/box
LM7908T	TO220-3L	LM7908	TUBE	1000pcs/box
LM7912T	TO220-3L	LM7912	TUBE	1000pcs/box
LM7915T	TO220-3L	LM7915	TUBE	1000pcs/box
LM7918T	TO220-3L	LM7918	TUBE	1000pcs/box
LM7924T	TO220-3L	LM7924	TUBE	1000pcs/box
LM7905S/TR	TO263-3L	LM7905	REEL	500 pcs/reel
LM7906S/TR	TO263-3L	LM7906	REEL	500 pcs/reel
LM7908S/TR	TO263-3L	LM7908	REEL	500 pcs/reel
LM7912S/TR	TO263-3L	LM7912	REEL	500 pcs/reel
LM7915S/TR	TO263-3L	LM7915	REEL	500 pcs/reel
LM7918S/TR	TO263-3L	LM7918	REEL	500 pcs/reel
LM7924S/TR	TO263-3L	LM7924	REEL	500 pcs/reel

ABSOLUTE MAXIMUM RATINGS

Maximum input voltage at $T_J=25^\circ\text{C}$	-35V
Maximum operating junction temperature	+125°C

ELECTRICAL CHARACTERISTICS LM7905 DIE ON WAFER

($V_{IN} = -10\text{V}$, $I_O = 500\text{mA}$, $C_{IN} = 2.2\mu\text{F}$, $C_O = 1.0\mu\text{F}$, $T_J = 25^\circ\text{C}$, unless otherwise noted)

CHARACTERISTIC	SYMBOL	TEST CONDITION	NORMS		UNIT
			Min	Max	
Output Voltage	V_O	$-7.0\text{V} \geq V_{IN} \geq -20\text{V}$ $5.0\text{mA} \leq I_O \leq 1.0\text{A}$	-4.82	-5.18	V
Line Regulation	ΔU_V	$I_O = 100\text{mA}$, $-7.0\text{V} \geq V_{IN} \geq -25\text{V}$ $I_O = 100\text{mA}$, $-8.0\text{V} \geq V_{IN} \geq -12\text{V}$ $I_O = 500\text{mA}$, $-7.0\text{V} \geq V_{IN} \geq -25\text{V}$ $I_O = 500\text{mA}$, $-8.0\text{V} \geq V_{IN} \geq -12\text{V}$		47.5 23.5 95 47.5	mV
Load Regulation	ΔU_I	$5.0\text{mA} \leq I_O \leq 1.5\text{A}$ $250\text{mA} \leq I_O \leq 750\text{mA}$		95 47.5	mV
Quiescent Current	I_B			7.8	mA
Quiescent Current Change	ΔI_B	$-7.0\text{V} \geq V_{IN} \geq -25\text{V}$ $5.0\text{mA} \leq I_O \leq 1.5\text{A}$		1.25 0.48	mA

ELECTRICAL CHARACTERISTICS LM7906 DIE ON WAFER

($V_{IN} = -11\text{V}$, $I_O = 500\text{mA}$, $C_{IN} = 2.2\mu\text{F}$, $C_O = 1.0\mu\text{F}$, $T_J = 25^\circ\text{C}$, unless otherwise noted)

CHARACTERISTIC	SYMBOL	TEST CONDITION	NORMS		UNIT
			Min	Max	
Output Voltage	V_O	$-8.0\text{V} \geq V_{IN} \geq -21\text{V}$ $5.0\text{mA} \leq I_O \leq 1.0\text{A}$	-5.77	-6.23	V
Line Regulation	ΔU_V	$I_O = 100\text{mA}$, $-8.0\text{V} \geq V_{IN} \geq -25\text{V}$ $I_O = 100\text{mA}$, $-9.0\text{V} \geq V_{IN} \geq -13\text{V}$ $I_O = 500\text{mA}$, $-8.0\text{V} \geq V_{IN} \geq -25\text{V}$ $I_O = 500\text{mA}$, $-9.0\text{V} \geq V_{IN} \geq -13\text{V}$		57 28.5 114 57	mV
Load Regulation	ΔU_I	$5.0\text{mA} \leq I_O \leq 1.5\text{A}$ $250\text{mA} \leq I_O \leq 750\text{mA}$		114 57	mV
Quiescent Current	I_B			7.8	mA
Quiescent Current Change	ΔI_B	$-8.0\text{V} \geq V_{IN} \geq -25\text{V}$ $5.0\text{mA} \leq I_O \leq 1.5\text{A}$		1.25 0.48	mA

ELECTRICAL CHARACTERISTICS LM7908 DIE ON WAFER

 ($V_{IN} = -14V$, $I_O = 500mA$, $C_{IN} = 2.2\mu F$, $C_O = 1.0\mu F$, $T_J = 25^\circ C$, unless otherwise noted)

CHARACTERISTIC	SYMBOL	TEST CONDITION	NORMS		UNIT
			Min	Max	
Output Voltage	V_O	$-10.5V \geq V_{IN} \geq -23V$ $5.0mA \leq I_O \leq 1.0 A$	-7.72	-8.28	V
Line Regulation	ΔU_V	$I_O = 100mA$, $-10.5V \geq V_{IN} \geq -25V$ $I_O = 100mA$, $-11V \geq V_{IN} \geq -17V$ $I_O = 500mA$, $-10.5V \geq V_{IN} \geq -25V$ $I_O = 500mA$, $-11V \geq V_{IN} \geq -17V$		76 38 152 76	mV
Load Regulation	ΔU_I	$5.0mA \leq I_O \leq 1.5 A$ $250mA \leq I_O \leq 750mA$		152 76	mV
Quiescent Current	I_B			7.8	mA
Quiescent Current Change	ΔI_B	$-10.5V \geq V_{IN} \geq -25V$ $5.0mA \leq I_O \leq 1.5 A$		0.98 0.48	mA

ELECTRICAL CHARACTERISTICS LM7912 DIE ON WAFER

 ($V_{IN} = -19V$, $I_O = 500mA$, $C_{IN} = 2.2\mu F$, $C_O = 1.0\mu F$, $T_J = 25^\circ C$, unless otherwise noted)

CHARACTERISTIC	SYMBOL	TEST CONDITION	NORMS		UNIT
			Min	Max	
Output Voltage	V_O	$-14.5V \geq V_{IN} \geq -21V$ $5.0mA \leq I_O \leq 1.0 A$	-11.52	-12.48	V
Line Regulation	ΔU_V	$I_O = 100mA$, $-14.5V \geq V_{IN} \geq -30V$ $I_O = 100mA$, $-16V \geq V_{IN} \geq -22V$ $I_O = 500mA$, $-14.5V \geq V_{IN} \geq -30V$ $I_O = 500mA$, $-16V \geq V_{IN} \geq -22V$		114 58.5 228 114	mV
Load Regulation	ΔU_I	$5.0mA \leq I_O \leq 1.5 A$ $250mA \leq I_O \leq 750mA$		228 114	mV
Quiescent Current	I_B			7.8	mA
Quiescent Current Change	ΔI_B	$-14.5V \geq V_{IN} \geq -30V$ $5.0mA \leq I_O \leq 1.5 A$		1.25 0.48	mA

ELECTRICAL CHARACTERISTICS LM7915 DIE ON WAFER

 ($V_{IN} = -23V$, $I_O = 500mA$, $C_{IN} = 2.2\mu F$, $C_O = 1.0\mu F$, $T_J = 25^\circ C$, unless otherwise noted)

CHARACTERISTIC	SYMBOL	TEST CONDITION	NORMS		UNIT
			Min	Max	
Output Voltage	V_O	$-17.5V \geq V_{IN} \geq -30V$ $5.0mA \leq I_O \leq 1.0 A$	-14.44	-15.56	V
Line Regulation	ΔU_V	$I_O = 100mA$, $-17.5V \geq V_{IN} \geq -30V$ $I_O = 100mA$, $-20V \geq V_{IN} \geq -26V$ $I_O = 500mA$, $-17.5V \geq V_{IN} \geq -30V$ $I_O = 500mA$, $-20V \geq V_{IN} \geq -26V$		142 71 285 142	mV
Load Regulation	ΔU_I	$5.0mA \leq I_O \leq 1.5 A$ $250mA \leq I_O \leq 750mA$		285 142	mV
Quiescent Current	I_B			7.8	mA
Quiescent Current Change	ΔI_B	$-17.5V \geq V_{IN} \geq -30V$ $5.0mA \leq I_O \leq 1.5 A$		0.98 0.48	mA

ELECTRICAL CHARACTERISTICS LM7918 DIE ON WAFER

 ($V_{IN} = -27V$, $I_O = 500mA$, $C_{IN} = 2.2\mu F$, $C_O = 1.0\mu F$, $T_J = 25^\circ C$, unless otherwise noted)

CHARACTERISTIC	SYMBOL	TEST CONDITION	NORMS		UNIT
			Min	Max	
Output Voltage	V_O	$-21V \geq V_{IN} \geq -33V$ $5.0mA \leq I_O \leq 1.0 A$	-17.34	-18.66	V
Line Regulation	ΔU_V	$I_O = 100mA$, $-21V \geq V_{IN} \geq -33V$ $I_O = 100mA$, $-24V \geq V_{IN} \geq -30V$ $I_O = 500mA$, $-21V \geq V_{IN} \geq -33V$ $I_O = 500mA$, $-24V \geq V_{IN} \geq -30V$		171 85.5 342 171	mV
Load Regulation	ΔU_I	$5.0mA \leq I_O \leq 1.5 A$ $250mA \leq I_O \leq 750mA$		342 171	mV
Quiescent Current	I_B			7.8	mA
Quiescent Current Change	ΔI_B	$-21V \geq V_{IN} \geq -33V$ $5.0mA \leq I_O \leq 1.5 A$		0.98 0.48	mA

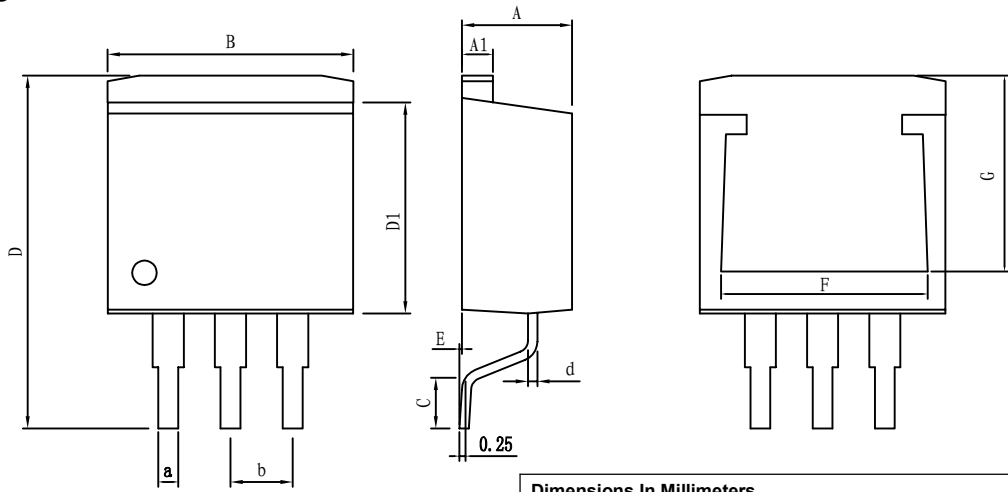
ELECTRICAL CHARACTERISTICS LM7924 DIE ON WAFER

 ($V_{IN} = -33V$, $I_O = 500mA$, $C_{IN} = 2.2\mu F$, $C_O = 1.0\mu F$, $T_J = 25^\circ C$, unless otherwise noted)

CHARACTERISTIC	SYMBOL	TEST CONDITION	NORMS		UNIT
			Min	Max	
Output Voltage	V_O	$-27V \geq V_{IN} \geq -38V$ $5.0mA \leq I_O \leq 1.0 A$	-23.05	-24.95	V
Line Regulation	ΔU_V	$I_O = 100mA$, $-27V \geq V_{IN} \geq -38V$ $I_O = 100mA$, $-30V \geq V_{IN} \geq -36V$ $I_O = 500mA$, $-27V \geq V_{IN} \geq -38V$ $I_O = 500mA$, $-30V \geq V_{IN} \geq -36V$		228 114 446 228	mV
Load Regulation	ΔU_I	$5.0mA \leq I_O \leq 1.5 A$ $250mA \leq I_O \leq 750mA$		446 228	mV
Quiescent Current	I_B			7.8	mA
Quiescent Current Change	ΔI_B	$-27V \geq V_{IN} \geq -33V$ $5.0mA \leq I_O \leq 1.5 A$		0.98 0.48	mA

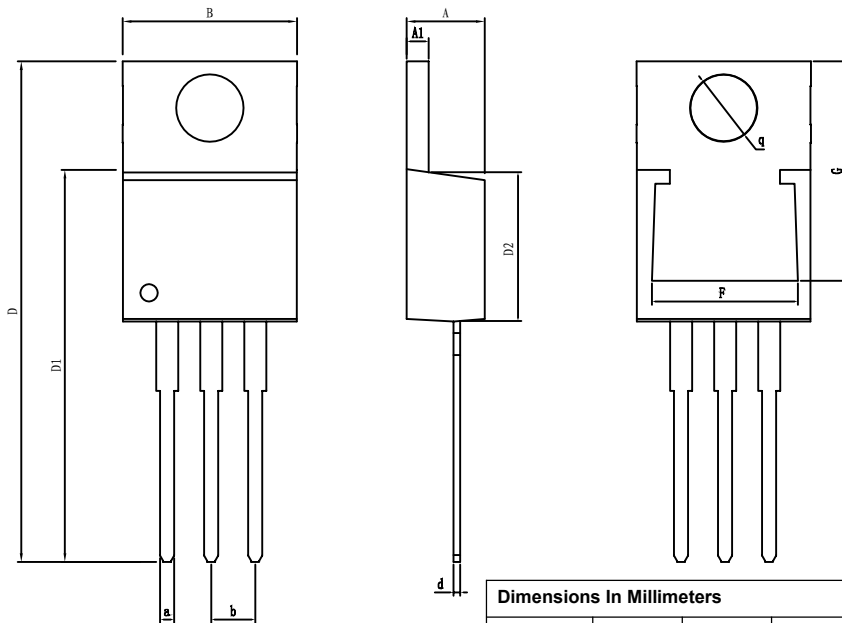
PACKAGE

T0263-3



Dimensions In Millimeters					
Symbol :	Min :	Max :	Symbol :	Min :	Max :
A	4.450	4.620	E	0	0.305
A1	1.220	1.320	F	8.332	8.532
B	10.03	10.41	G	12.555	12.755
C	1.890	2.190	a	0.690	0.940
D	13.750	14.650	b	2.290	2.790
D2	8.380	8.890	d	0.350	0.560

T0220-3



Dimensions In Millimeters					
Symbol :	Min :	Max :	Symbol :	Min :	Max :
A	4.450	4.620	F	8.332	8.532
A1	1.220	1.320	G	12.555	12.755
B	10.03	10.54	a	0.690	0.940
D	25.53	26.29	b	2.290	2.790
D1	22.420	22.620	d	0.350	0.560
D2	8.380	8.890	q	3.780	3.980

Important statement:

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